10/560155

IAP13 Rec'd PCT/PTO 09 DEC 2005

SHIGA7.034APC PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant

WASHIO, Y. et al.

Appl. No.

Unknown

Filed

: Herewith

For

DEVELOPER COMPOSITION

FOR RESISTS AND METHOD FOR FORMATION OF RESIST

PATTERN

Examiner

Unknown

Group Art Unit

Unknown

PRELIMINARY AMENDMENT

Mail Stop Amendment

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

Preliminary to examination on the merits, please amend the above-captioned U.S. National Phase Application as follows:

Amendments to the Specification begin on page 2 of this paper.

Amendments to the Claims are reflected in the listing of claims which begins on page 3 of this paper.

Remarks/Arguments begin on page 4 of this paper.